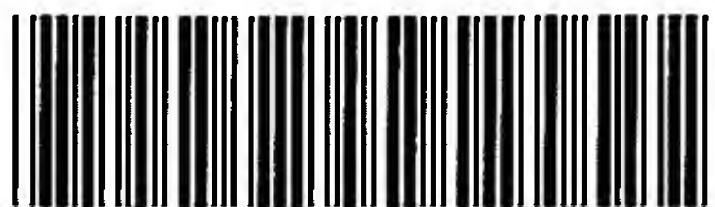


Search Notes**Application/Control No.**

10/710,484

Examiner

Ahshik Kim

Applicant(s)/Patent under Reexamination

BISHOP ET AL.

Art Unit

2876

SEARCHED

Class	Subclass	Date	Examiner
235	379	5/27/2005	AK
	380		
	382		
	382.5		
	383		
705	35		
	41		
	44		
	68		
	70		
	75		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
same as	above	7/22/2005	AK

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Reviewed parent application 10/242,584	5/27/2005	AK
updated search	7/22/2005	AK